

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/581,787	JACOBSSON ET AL.		
Examiner	Art Unit		
Hai L. Nguyen	2816		

SEARCHED					
Class	Subclass	Date	Examiner		
327	113, 114, 116,119,	11/10/2007	HLN		
377	47, 48	11/12/2007	HLN		
331	53	11/12/2007	HLN		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH I (INCLUDING SEAR)
	DATE	EXMR
Shepardize Search, see search history printout	11/10/2007	HLN
Shepardize Search, see search history printout	11/12/2007	HLN
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